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Steep Dispersion Engineering and Opto-Atomic Precision Metrology XI

**Selim M. Shahriar
Jacob Scheuer**
Editors

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Contents

- v *Authors*
- vii *Conference Committee*

PHOTONIC CRYSTALS

- 10548 04 **Adaptive detection of optical phase modulation in acetylene-filled hollow-core photonic crystal fibers (Invited Paper)** [10548-3]
- 10548 06 **Controllable low-loss slow light in photonic crystals (Invited Paper)** [10548-5]

NEW DEVELOPMENTS IN SLOW AND FAST LIGHT

- 10548 09 **Optimal interfacing with coupled-cavities slow-light waveguides: mimicking periodic structures with a compact device** [10548-8]

STEEP DISPERSION-BASED SENSING

- 10548 0F **Miniature optical fiber strain sensor based on Fabry-Perot interferometer (Invited Paper)** [10548-14]
- 10548 0G **Absorption sensing enhancement in a microresonator coupled to a non-adiabatic tapered fiber (Invited Paper)** [10548-15]

OPTICAL COMPUTING, DELAY LINES, AND STORAGE

- 10548 0H **The characteristics and arithmetic of a novel structure based on add-drop resonator** [10548-16]
- 10548 0J **RF photonic delay lines using space-division multiplexing (Invited Paper)** [10548-18]

PLASMONICS

- 10548 0N **Sub-wavelength microscopy with surface plasmons (Invited Paper)** [10548-23]

NANOPHOTONIC DEVICES

- 10548 0S **Double-ring optical resonator gyroscopes using 3x3 fiber couplers (Invited Paper)** [10548-28]

NONLINEAR EFFECTS FOR STEEP DISPERSION

- 10548 0U **Dispersion engineering with stimulated Brillouin scattering and applications (Invited Paper)** [10548-30]
- 10548 0X **Effect of particular nonlinear dispersion in photorefractive four-wave mixing on slow and fast light (Invited Paper)** [10548-33]

FAST LIGHT, NON-RECIPROCITY, PT SYMMETRY, AND RELATED TOPICS

- 10548 12 **Time cloak based on slow/fast light effects in fiber Mach-Zehnder interferometers (Invited Paper)** [10548-37]

INTEGRATED AND NANOTECHNOLOGY FOR PRECISION METROLOGY AND DISPERSION ENGINEERING

- 10548 1G **Fully integrated standalone zero field optically pumped magnetometer for biomagnetism (Invited Paper)** [10548-51]

QUANTUM TECHNOLOGIES FOR PRECISION METROLOGY AND SENSING

- 10548 1K **Quantum astronomy: scientific background, technologies, achieved results, and future developments (Invited Paper)** [10548-55]

ATOM INTERFEROMETRY

- 10548 1X **Simple, precise, and versatile atom interferometer for field applications (Invited Paper)** [10548-68]
- 10548 1Y **Raman spectroscopy using a continuous beam from a 2D MOT (Invited Paper)** [10548-69]

POSTER SESSION

- 10548 20 **Atomic clock stability under dynamic excitation of coherent population trapping resonance in cells without buffer gas** [10548-71]

Authors

Numbers in the index correspond to the last two digits of the seven-digit citation identifier (CID) article numbering system used in Proceedings of SPIE. The first five digits reflect the volume number. Base 36 numbering is employed for the last two digits and indicates the order of articles within the volume. Numbers start with 00, 01, 02, 03, 04, 05, 06, 07, 08, 09, 0A, 0B...0Z, followed by 10-1Z, 20-2Z, etc.

Al-Amri, M., 0N	Xian, Tian-hao, 12
Alem, O., 1G	Yuan, Ping, 0F, 0H
Andryushkov, Valerii , 20	Zampieri, L., 1K
Barbieri, C., 1K	Zeng, Xiaodong, 0N
Boyd, Robert W., 06	Zhan, Li, 12
Canoza, Philip, 1X	Zhang, Wen-yan, 12
Casillas, Nayeli, 04	Zhang, Yundong, 0F, 0H
Davis, Jon P., 1Y	Zhao, Yongpeng, 0F
Digonnet, Michel J. F., 0S	Zi, Fei, 1X
Dudley, Jordan, 1X	Zubairy, M. Suhail, 0N
Evans, Dean R., 0X	
Feng, Cheng, 0U	
Gao, Lirun, 12	
García, S., 0J	
Gasulla, I., 0J	
Grant, Matthew J., 0S	
Hernández, Eliseo, 04	
Hu, Changyu, 06	
Khripunov, Sergey, 20	
Kobtsev, Sergey, 20	
Li, Chao, 12	
Ma, Kai, 0F, 0H	
Malek, Bola, 1X	
Manicchia, Michael, 1Y	
Mathey, Pierre, 0X	
Meldrum, Aaron, 1Y	
Müller, Holger, 1X	
Naletto, G., 1K	
Narducci, Frank A., 1Y	
Occhipinti, T., 1K	
Ocegueda, Manuel, 04	
O'Faolain, Liam, 06	
Orton, J., 1G	
Osborne, J., 1G	
Pagel, Zachary, 1X	
Popkov, Ivan, 20	
Preussler, Stefan, 0U	
Radnatarov, Daba, 20	
Rosenberger, A. T., 0G	
Scheuer, Jacob, 09	
Schneider, Thomas, 0U	
Schulz, Sebastian A., 06	
Shah, V., 1G	
Shcherbin, Konstantin, 0X	
Stepanov, Serguei, 04	
Steschenko, Tatiana, 20	
Su, Huaiyin, 0F, 0H	
Upham, Jeremy, 06	
Wu, Xuejian, 1X	

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- 1 Photonic Crystals
Robert W. Boyd, University of Ottawa (Canada) and University of Rochester (United States)
Avinoam Zadok, Bar-Ilan University (Israel)
- 2 New Developments in Slow and Fast Light
Luc Thévenaz, Ecole Polytechnique Fédérale de Lausanne (Switzerland)
- 3 Steep Dispersion-based Sensing
Zheng Wang, The University of Texas at Austin (United States)
- 4 Optical Computing, Delay Lines, and Storage
Yuval Yifat, The James Franck Institute (United States)
- 5 Tutorial
Jacob Scheuer, Tel Aviv University (Israel)
- 6 Plasmonics
Jacob B. Khurgin, Johns Hopkins University (United States)
- 7 Nanophotonic Devices
Avinoam Zadok, Bar-Ilan University (Israel)
- 8 Nonlinear Effects for Steep Dispersion
Misha Sumetsky, Aston University (United Kingdom)
- 9 Fast Light, Non-Reciprocity, PT Symmetry, and Related Topics
Aleksander K. Rebane, Montana State University (United States)
- 10 Quantum Control Spin Squeezing and Related Technologies
Liron Stern, The Hebrew University of Jerusalem (Israel)
- 11 Atomic Clocks, Atomic Interferometers, and Enabling Technologies
Onur Hosten, University of Illinois (United States)

- 12 Integrated and Nanotechnology for Precision Metrology and Dispersion Engineering
Scott Papp, National Institute of Standards and Technology
(United States)
- 13 Quantum Technologies for Precision Metrology and Sensing
Andrey B. Matsko, OEwaves, Inc. (United States)
- 14 New Developments in Precision Metrology
Philip R. Hemmer, Texas A&M University (United States)
- 15 Atom Interferometry
Philippe Bouyer, Laboratoire Photonique, Numérique et Nanosciences
(France)

